

Y30NK90Z-VB Datasheet

N-Channel 900V(D-S) Super Junction Power MOSFET

PRODUCT SUMMARY

| | | |
|------------------------------------|-----------------|-------|
| V_{DS} (V) at T_J max. | 950 | |
| $R_{DS(on)}$ at 25 °C (Ω) | $V_{GS} = 10$ V | 0.085 |
| Q_g max. (nC) | 293 | |
| Q_{gs} (nC) | 46 | |
| Q_{gd} (nC) | 79 | |
| Configuration | Single | |

FEATURES

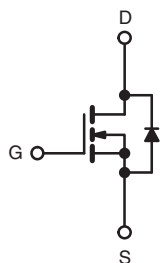
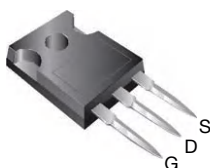
- Low figure-of-merit (FOM) $R_{on} \times Q_g$
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Q_g)
- Avalanche energy rated (UIS)


RoHS
 COMPLIANT

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

TO-247AC



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)

| PARAMETER | SYMBOL | LIMIT | UNIT |
|---|------------------|----------------|------|
| Drain-Source Voltage | V_{DS} | 900 | V |
| Gate-Source Voltage | V_{GS} | ± 30 | |
| Continuous Drain Current ($T_J = 150$ °C) | V_{GS} at 10 V | $T_C = 25$ °C | A |
| | | $T_C = 100$ °C | |
| Pulsed Drain Current ^a | I_{DM} | 142 | |
| Linear Derating Factor | | 3.3 | W/°C |
| Single Pulse Avalanche Energy ^b | E_{AS} | 1510 | mJ |
| Maximum Power Dissipation | P_D | 465 | W |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | -55 to +150 | °C |
| Drain-Source Voltage Slope | dV/dt | $T_J = 125$ °C | V/ns |
| Reverse Diode dV/dt ^d | | | |
| Soldering Recommendations (Peak Temperature) ^c | | for 10 s | °C |


Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DS} = 50$ V, starting $T_J = 25$ °C, $L = 28.2$ mH, $R_g = 25$ Ω , $I_{AS} = 10$ A.
- 1.6 mm from case.
- $I_{SD} \leq I_D$, $dI/dt = 100$ A/ μ s, starting $T_J = 25$ °C.

THERMAL RESISTANCE RATINGS

| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
|----------------------------------|------------|------|------|------|
| Maximum Junction-to-Ambient | R_{thJA} | - | 40 | °C/W |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 0.3 | |

SPECIFICATIONS ($T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|----------------------------------|---|--|------|-------|-------|------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | | 900 | - | - | V |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | Reference to 25 °C, I _D = 1 mA | | - | 0.70 | - | V/°C |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250 μA | | 2 | - | 4 | V |
| Gate-Source Leakage | I _{GSS} | V _{GS} = ± 20 V | | - | - | ± 100 | nA |
| | | V _{GS} = ± 30 V | | - | - | ± 1 | μA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 900V, V _{GS} = 0 V | | - | - | 1 | μA |
| | | V _{DS} = 720V V _{GS} = 0 V, T _J = 125 °C | | - | - | 25 | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 24 A | - | 0.085 | - | Ω |
| Forward Transconductance | g _{fs} | V _{DS} = 30 V, I _D = 24 A | | - | 16.7 | - | S |
| Dynamic | | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz | | - | 6282 | - | pF |
| Output Capacitance | C _{oss} | | | - | 251 | - | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 1 | - | |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | V _{DS} = 0 V to 720V, V _{GS} = 0 V | | - | 192 | - | pF |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | | | - | 665 | - | |
| Total Gate Charge | Q _g | V _{GS} = 10 V | I _D = 24 A, V _{DS} = 720 V | - | 192 | 293 | nC |
| Gate-Source Charge | Q _{gs} | | | - | 46 | - | |
| Gate-Drain Charge | Q _{gd} | | | - | 79 | - | |
| Turn-On Delay Time | t _{d(on)} | V _{DD} = 720 V, I _D = 6 A, V _{GS} = 10 V, R _g = 9.1 Ω | | - | 47 | 94 | ns |
| Rise Time | t _r | | | - | 87 | 131 | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 156 | 234 | |
| Fall Time | t _f | | | - | 103 | 206 | |
| Gate Input Resistance | R _g | f = 1 MHz, open drain | | - | 0.64 | - | Ω |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode  | | - | - | 47 | A |
| Pulsed Diode Forward Current | I _{SM} | | | - | - | 139 | |
| Diode Forward Voltage | V _{SD} | T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V | | - | 0.9 | 1.2 | V |
| Reverse Recovery Time | t _{rr} | T _J = 25 °C, I _F = I _S = 24 A, di/dt = 100 A/μs, V _R = 25 V | | - | 753 | 1506 | ns |
| Reverse Recovery Charge | Q _{rr} | | | - | 14 | 28 | μC |
| Reverse Recovery Current | I _{RRM} | | | - | 28 | - | A |

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .
 b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

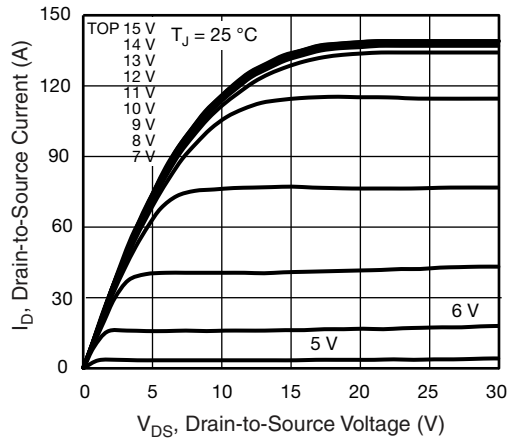


Fig. 1 - Typical Output Characteristics

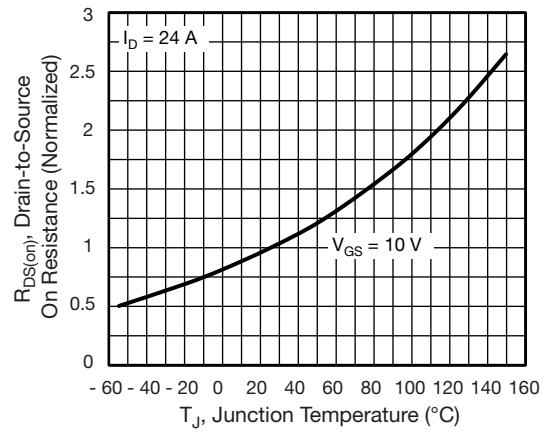


Fig. 4 - Normalized On-Resistance vs. Temperature

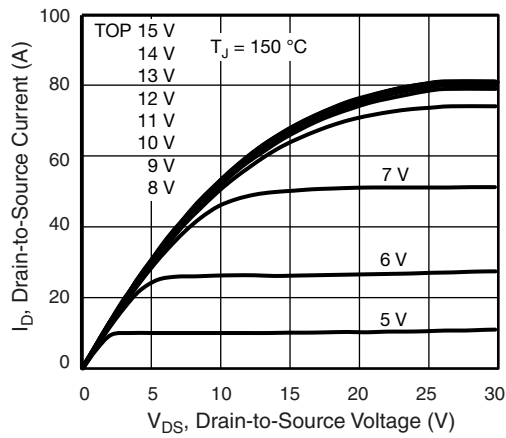


Fig. 2 - Typical Output Characteristics

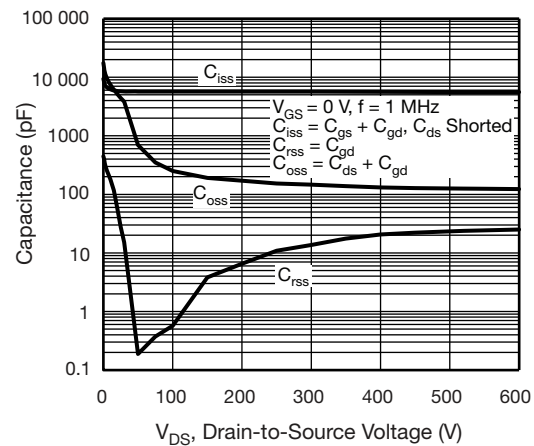


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

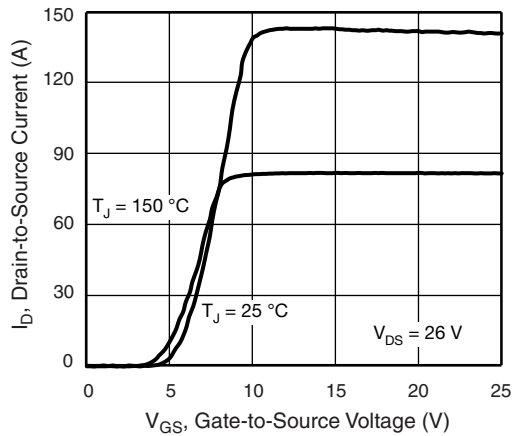


Fig. 3 - Typical Transfer Characteristics

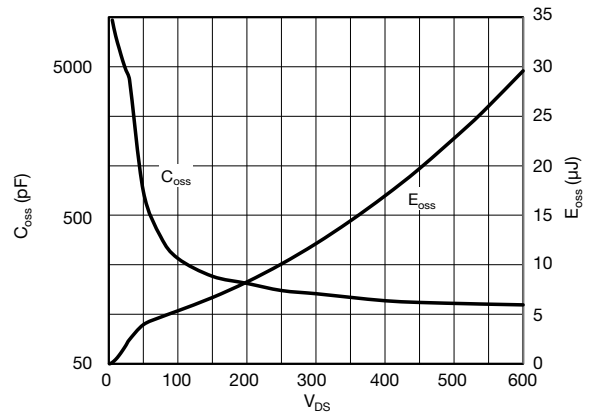


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}

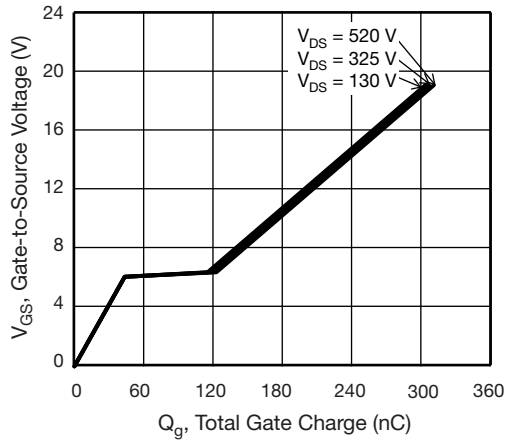


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage



Fig. 10 - Maximum Drain Current vs. Case Temperature

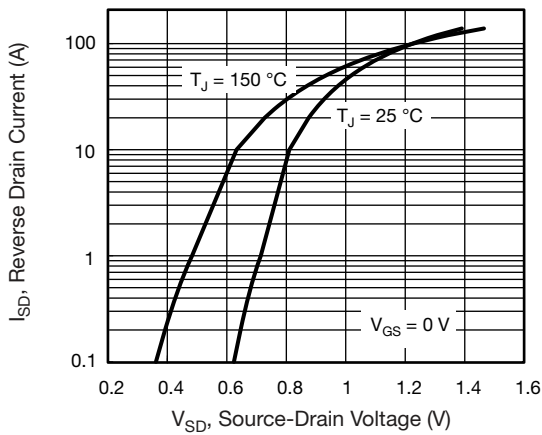


Fig. 8 - Typical Source-Drain Diode Forward Voltage



Fig. 11 - Temperature vs. Drain-to-Source Voltage

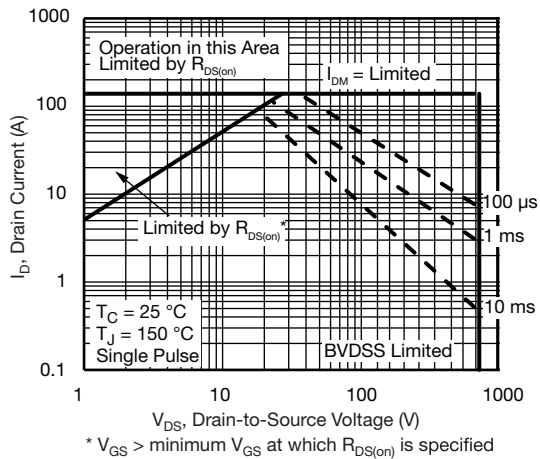
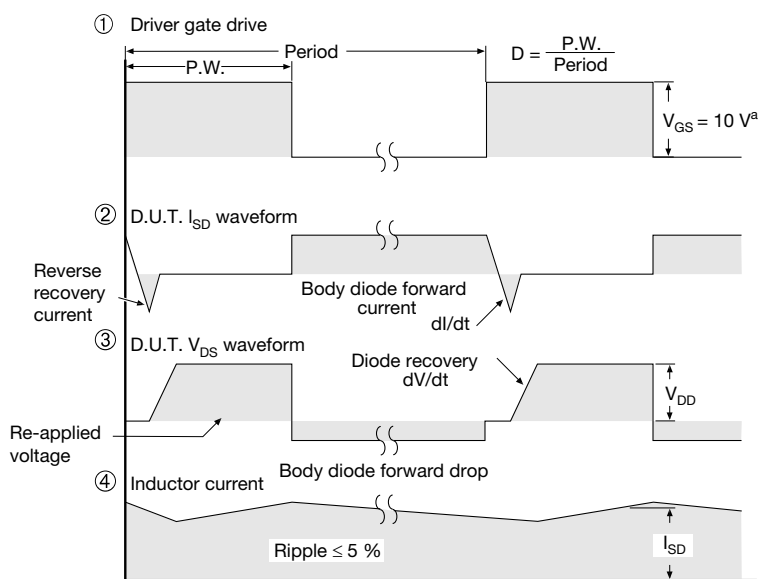
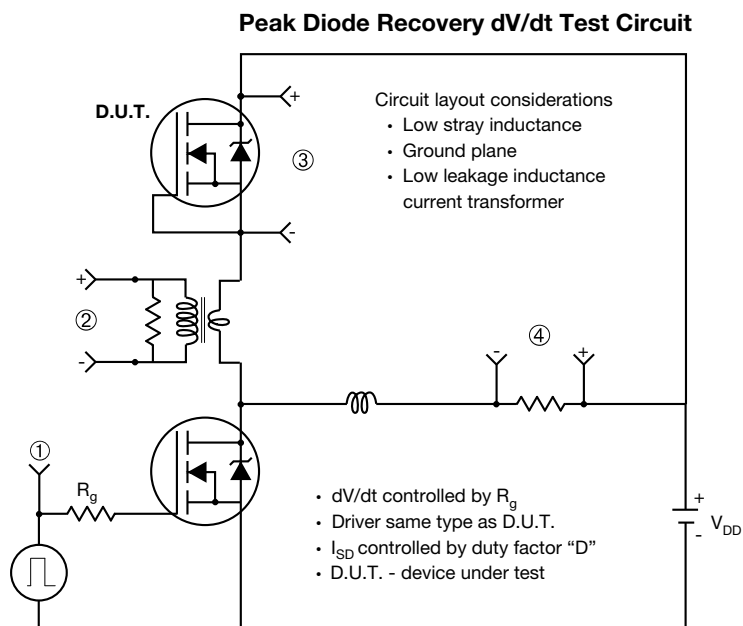


Fig. 9 - Maximum Safe Operating Area



**Note**a. $V_{GS} = 5\text{ V}$ for logic level devices**Fig. 19 - For N-Channel**

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